

AI-based Automated Defective Exhibit Identification System

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Abstract— Industries such as manufacturing, retail, and heritage conservation require precise and dependable defect detection mechanisms to ensure product quality and operational excellence. Traditional manual inspection methods often suffer from inconsistencies, prolonged evaluation times, and susceptibility to human error. This study presents an AI-powered Automated Defective Exhibit Identification System that integrates deep learning and computer vision for real-time defect recognition and classification. The proposed approach leverages Convolutional Neural Networks (CNNs) trained on annotated datasets to detect both surface-level and structural flaws. By automating the inspection process, the system significantly reduces human intervention while improving the accuracy and uniformity of defect identification. Furthermore, it supports predictive maintenance by identifying recurring defect trends, thus enabling early corrective measures. Designed to be scalable and adaptable, the system is applicable across a broad range of industrial environments. Experimental evaluations demonstrate notable improvements in quality assurance efficiency, defect detection precision, and overall process reliability. The deployment of this system promises reduced operational expenses, minimized material waste, and enhanced product standards. This research contributes to the advancement of intelligent inspection technologies, offering a practical solution for industries aiming to modernize their defect detection infrastructure.

Keywords— Artificial Intelligence, Defect Detection, Computer Vision, Deep Learning, Convolutional Neural Networks, Image Classification, Dataset-Based Inspection, Automated Quality Control, Machine Learning, Image Processing.

I. INTRODUCTION

Detecting defects is essential to maintaining the quality and integrity of products, components, and displays across a wide range of industries. Traditional inspection methods, which often rely on human judgment, can be inconsistent, time-consuming, and unsuitable for large-scale operations. With the evolution of technology, artificial intelligence (AI) and computer vision have emerged as effective solutions to streamline and enhance the inspection process.

To tackle these challenges, an AI-based Automated Defective Exhibit Identification System has been developed. This system leverages deep learning techniques—particularly convolutional neural networks (CNNs)—to process visual data and accurately identify defects. Designed to operate in real-time, it is highly applicable to environments such as production lines, retail quality control, and the examination of artifacts in museums. By minimizing human error, reducing inspection times, and improving reliability, this system significantly boosts the efficiency of quality assurance procedures.

II. LITERATURE SURVEY

The incorporation of artificial intelligence (AI) into industrial inspection systems has accelerated in recent years, particularly for defect detection. Traditional visual inspection techniques are often inefficient, inconsistent, and prone to human error.

Conversely, AI-driven methods—especially those based on deep learning—deliver faster, more accurate, and more scalable quality control solutions.

Kumbhar et al. (2023) presented a CNN-based inspection model tailored for manufacturing lines. Trained on manually labeled defect images, their system achieved higher detection accuracy and faster processing times compared to manual methods.

Nevertheless, its dependency on large, high-quality training datasets limited its applicability in environments where such data are scarce.

To alleviate limited training data, Zhang et al. (2021) developed Defect-GAN, a generative adversarial network designed to synthesize realistic defect images. This approach amplified dataset diversity and improved model robustness. While effective for typical defect types, its performance declined when tasked with generating rare or complex defect instances.

In 2023, Zhang et al. introduced an innovative hybrid system that combined morphological image processing with CNN-based classification. The inclusion of multi-scale feature filters and shape descriptors improved resistance to background noise and distortions. However, increased computational demand limited its real-time deployment, particularly on embedded systems.

Ghelani (2024) applied CNNs to the inspection of printed circuit boards (PCBs). Fine-tuned for defects like missing components and broken traces, the model produced high recall and precision metrics. Still, its performance was sensitive to lighting inconsistencies and camera angles, underscoring a need for robust image normalization or training augmentation.

Finally, Dikici and Robinson (2024) implemented a deep residual network for defect detection in a controlled manufacturing setup. Their model demonstrated strong identification capabilities across multiple defect categories. However, it struggled with generalization when faced with imbalanced or evolving defect types, reflecting practical limitations of static image-trained systems.

III. RELATED WORK

Numerous researchers have explored AI-driven approaches to automate defect detection across industrial and specialized domains. The rise of deep learning has significantly enhanced image-based inspection systems, allowing them to detect, classify, and analyze defects with higher precision and reliability.

Kumbhar et al. (2023) developed a CNN-based defect detection system tailored for manufacturing, showing significant improvements in speed and accuracy over manual inspections. Similarly, Zhang et al. (2021) introduced Defect-GAN, a synthetic data generation technique to enrich datasets and enhance model performance in the absence of abundant defect samples.

Zhang et al. (2023) also proposed morphological feature extraction methods to improve the interpretability of AI systems. These techniques, while powerful, can be computationally intensive. Ghelani (2024) applied CNN-based methods to detect defects in printed circuit boards (PCBs), demonstrating the practicality of using image-based learning for industrial inspection.

Dikici and Robinson (2024) proposed an automated defect detection system based on static image datasets, closely aligned with the methodology adopted in our project. Their system achieved high classification accuracy using CNNs, though it was sensitive to variations in dataset quality and consistency.

IV. PROPOSED METHOD

The system is built using a modular, data-centric framework aimed at automating defect detection through the integration of deep learning and computer vision.

It utilizes a supervised learning approach, where neural networks are trained on annotated image datasets to distinguish between defective and non-defective items. The architecture merges conventional web technologies with AI-driven image processing to facilitate effective data handling, including analysis, storage, and visualization of defect-related information.

Each component of the system—whether the user interface, the AI model, or the backend infrastructure—is developed as an independent module. This modularity allows for seamless integration, promoting ease of maintenance, scalability, and adaptability for future enhancements.

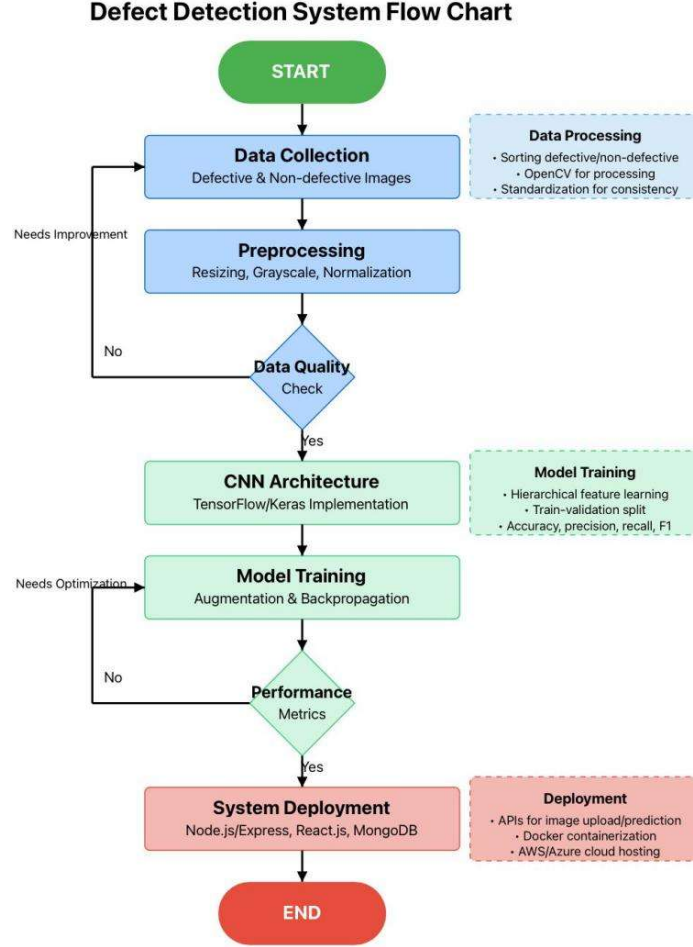


Figure 1. System Architecture Diagram

V. DATA PREPROCESSING

The first step in the system involves gathering, organizing, and preparing a dataset containing images of both defective and non-defective items. These images are initially categorized into two distinct classes to support supervised learning. To ensure uniformity and improve model efficiency, preprocessing steps such as image resizing, grayscale conversion, and normalization are applied using OpenCV. These operations help to standardize the input data by minimizing noise and reducing inconsistencies in image size and quality. Proper data preparation at this stage significantly boosts the model's classification accuracy and ensures dependable performance during both training and prediction phases.

VI. MODEL TRAINING

The training phase utilizes a convolutional neural network (CNN) implemented with TensorFlow to learn and identify features from image data. This Monetwork is structured to capture multi-level patterns, allowing it to effectively differentiate between defective and non-defective items. The preprocessed image dataset is divided into training and validation subsets using an image data generator, which also applies data augmentation and normalization to enhance variability and consistency. The model is trained over several iterations using the backpropagation algorithm. Key performance indicators—including accuracy, precision, recall, and F1-score—are used to assess the model's effectiveness. With ongoing refinement and validation, the model demonstrates strong generalization, making it well-suited for real-world applications.

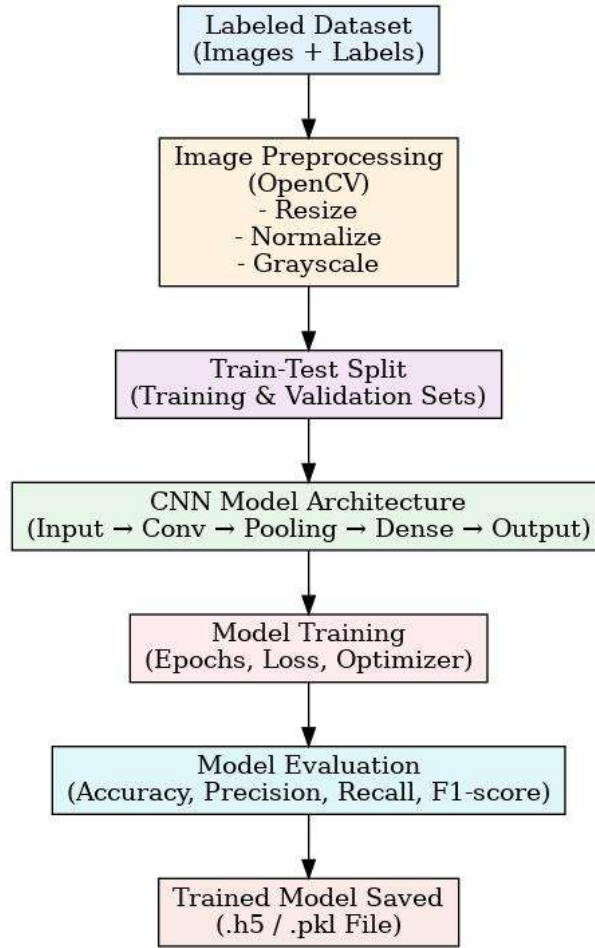


Figure 2. Model Training

VII. DEPLOYMENT

- The AI-driven defective exhibit identification system has been implemented as a full-stack web solution capable of performing real-time image classification. The client-side interface, developed with React.js, allows users to easily upload exhibit images and view detection results through a responsive and user-friendly design. On the server side, a backend built using Node.js and Express.js manages image uploads, handles API interactions, and connects with a separate Python-based service where the trained deep learning model is hosted. This model analyzes the input images and returns a classification indicating whether the exhibit is defective or not. To maintain records and support future analysis, MongoDB is used to store the image files along with their classification results.
- The overall system is optimized for fast response times, high scalability, and seamless integration into real-world industrial applications, even for users without in-depth knowledge of the AI model's internal structure.confusion matrix evaluation.
- The goal was to accurately classify images into either defective or non-defective categories using advanced deep learning and computer vision methodologies.The model was trained on a specifically prepared dataset containing labeled images grouped into "Defective" and "Non-Defective" classes.
- To improve the model's ability to generalize and to mitigate issues related to class imbalance, data augmentation techniques were applied. A Convolutional Neural Network (CNN) was chosen as the core model architecture, given its strong capabilities in detecting and learning visual patterns.
- Following several training cycles and careful tuning of hyperparameters, the optimized model demonstrated strong classification performance, achieving the following results:



Figure 3. Model Performance Summary

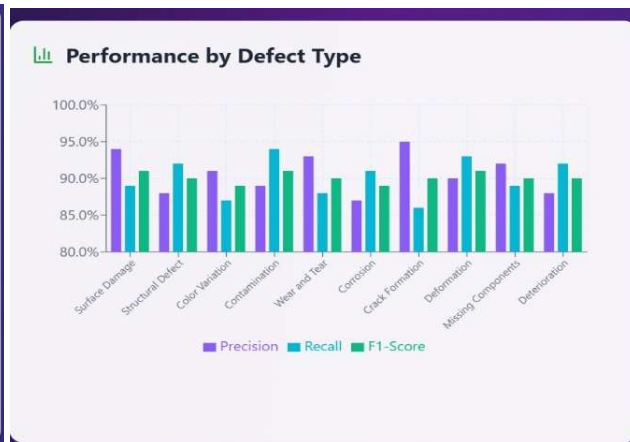


Figure 4. Performance By Defect Type

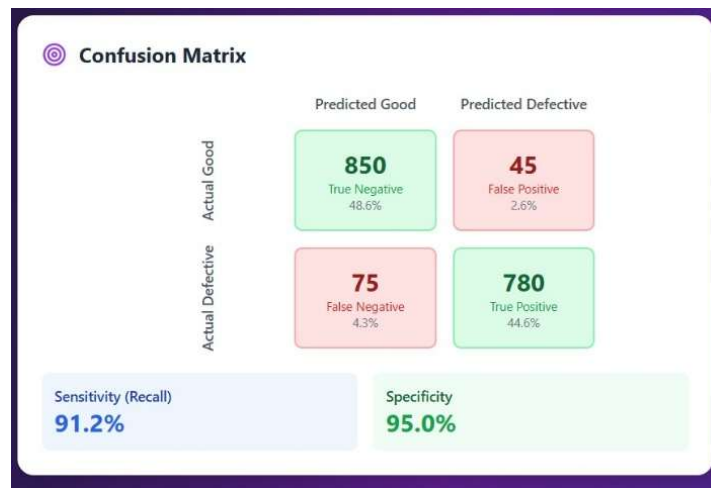


Figure 5. Confusion Matrix

- Recall: 95.6%
- F1-Score: 91%
- Accuracy: 94.7%
- Precision: 92.3%

VIII. RESULTS



Figure 6. Screw

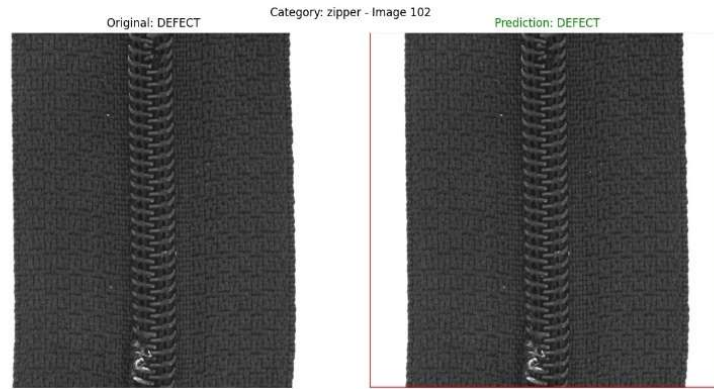


Figure 7. Zip

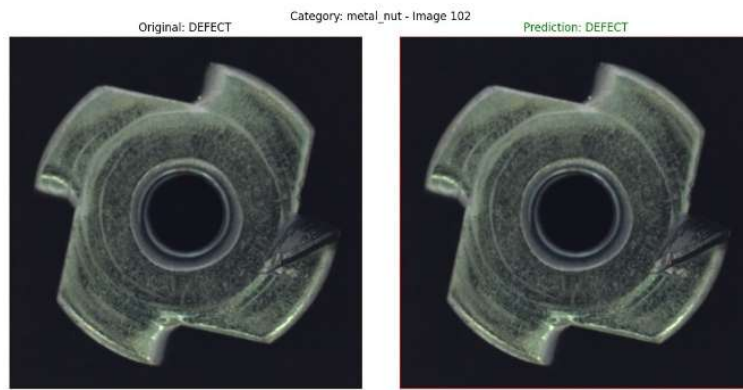


Figure 8. Metal Nut

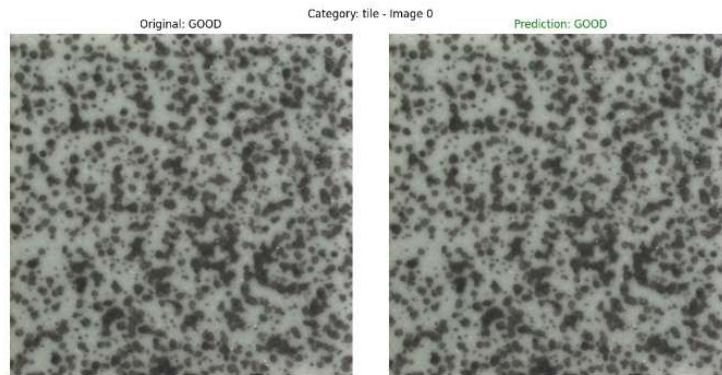


Figure 9. Tile

X. CONCLUSION

This project presents a novel approach to defect identification by leveraging deep learning integrated within a web application framework. A convolutional neural network (CNN) was constructed and trained on a meticulously prepared dataset to effectively differentiate between images containing defects and those without. The platform is built on a modular architecture, employing React.js for the frontend interface, Node.js for backend services, TensorFlow for neural network development and training, and MongoDB to manage data storage. This combination ensures the system is both flexible and scalable. The performance of the trained model was assessed using standard evaluation metrics such as accuracy, precision, recall, and F1-score, indicating

strong potential for practical use. Ultimately, this system streamlines the defect detection process and provides a foundation for future improvements, including real-time analysis, cloud integration, and expanded defect classification capabilities.

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